Amendment under 37 CFR 1.111 Shigeo OHSAKA et al.

U.S. Patent Application Serial No. 09/456,531 Attorney Docket No. 991387

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side surfaces of the poles and formed of an insulation material having a higher hardness than polyimide, and a second film of polyimide buried among said a plurality of poles with the first film formed on the side surfaces thereof.

3. (Twice Amended) A semiconductor light-emitting device having an electrode structure including a bonding pad formed on an insulation film without penetrating the insulation film, the insulation film being formed above a base substrate,

the insulation film comprising a plurality of poles of polyimide, a first film formed on each side surfaces of the poles and formed of an insulation material having a higher hardness than polyimide, and a second film of polyimide buried among said a plurality of poles with the first film formed on side surfaces thereof.

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- 6. (Amended) A semiconductor light-emitting device according to claim 3, wherein the first film is also formed on upper surfaces of the second film.
- 7. (Thrice Amended) A semiconductor light-emitting device according to claim 3, wherein a third film of an insulation material is sandwiched between the insulation film and the bonding pad.
  - 11. (Amended) A semiconductor light-emitting device according to claim 3, wherein the insulation film is formed on a layer formed on the base substrate, the layer being formed

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of a material having a higher hardness than the polyimide.

13. (Thrice Amended) A semiconductor light-emitting device including a waveguide, a lower electrode formed below the waveguide, and an upper electrode formed above the waveguide, the upper electrode having an electrode structure,

the electrode structure including a bonding pad formed on an insulation film without penetrating the insulation film, the insulation film being formed above a base substrate,

the insulation film comprising a plurality of poles of polyimide, a first film formed on each side surfaces of the poles and formed of an insulation material having a higher hardness than polyimide, and a second film of polyimide buried among said a plurality of poles with the first film formed on the side surfaces thereof.

- 19. (New) An electrode structure according to claim 1, wherein the first film is also formed on upper surfaces of the poles.
- 20. (New) An electrode structure according to claim 1, wherein the first film is also formed on upper surfaces of the second film.
  - 21. (New) A semiconductor light-emitting device according to claim 13, wherein the first film is also formed on upper surfaces of the poles.

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22. (New) A semiconductor light-emitting device according to claim 13, wherein

the first film is also formed on upper surfaces of the second film.

